

Attorney's Docket No. 5308-168

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re: Das et al. Confirmation No.: 2584
Serial No.: 09/878,442 Group Art Unit: 2815
Filed: June 11, 2001 Examiner: J. Jackson, Jr.
For: HIGH VOLTAGE, HIGH TEMPERATURE CAPACITOR STRUCTURES
AND METHODS OF FABRICATING SAME

Date: July 16, 2003

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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INFORMATION DISCLOSURE STATEMENT TECHNOLOGY CENTER 2800
PURSUANT TO 37 C.F.R. § 1.97(d)

Sir:

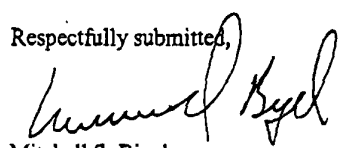
This is an Information Disclosure Statement in accordance with 37 C.F.R. § 1.97(d) and a petition for consideration of an Information Disclosure Statement in accordance with 37 C.F.R. § 1.97(d)(2). Please charge Deposit Account No. 50-0220 in the amount of \$180.00 for the petition fee set forth in 37 C.F.R. § 1.17(i) as required by 37 C.F.R. § 1.92(d)(3). The Commissioner is authorized to charge any additional fee, or credit any refund, to our Deposit Account No. 50-0220.

This Information Disclosure Statement is being filed after a Notice of Allowance under 37 C.F.R. § 1.311, but before payment of the Issue Fee. The Notice of Allowance was mailed on June 18, 2003.

Attached is a list of documents on form PTO-1449 together with copies of each identified document. In accordance with the requirements of 37 C.F.R. § 1.97(d)(1), the following Certification as specified in 37 C.F.R. § 1.97(e) is made. Each item of information contained in this Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart application not more than three (3) months prior to the filing of this Information Disclosure Statement.

08/11/2003 TLUU11 00000007 500220 09878442
01 FC:1806 180.00 DA

Respectfully submitted,


Mitchell S. Bigel
Registration No. 29,614

FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)					Attorney Docket Number 5308-168		Serial No. 09/878,442	
					Applicants: Das et al.			
					Filing Date: June 11, 2001			Group 2815
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
	1	5,587,870	12/24/96	Anderson et al.	361	313		
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation Yes No	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
	2	Wang et al. "High Temperature Characteristics of High-Quality SiC MIS Capacitors with O/N/O Gate Dielectric," <i>IEEE Transactions on Electron Devices</i> , Vol. 47, No. 2, February 2000.						
	3	Invitation to Pay Additional Fees for PCT/US02/09393 dated 7/7/03.						

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Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.